## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10719738	CHANG, YICHENG
Examiner	Art Unit
Pervan, Michael	2629

SEARCHED						
Class	Subclass	Date	Examiner			
345	89	9/25/2006	MP			
345	690	9/25/2006	MP			
above	updated	3/22/2007	MP			
above	updated	7/31/2007	MP			
above	updated	1/17/2008	MP			

SEARCH NOTES				
Search Notes	Date	Examiner		
see attached EAST search results	9/27/2006	MP		
consulted Amr Awad for class/subclass search	9/15/2006	MP		
consulted Regina Liang	9/22/2006	MP		
see attached updated EAST search results	3/22/2007	MP		
see attached updated EAST search results	7/31/2007	MP		
see attached updated EAST search results	1/17/2008	MP		
Interference search: ((first near5 frequency) and (second near5 frequency) and (primary near5 subframe) and (secondary near5 subframe) and ((stressed overused aged) near5 pixel)).clm.	1/17/2008	MP		

INTERFERENCE SEARCH						
Class		Subclass	Date	Examiner		
345	89, 690		1/17/2008	MP		

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